

Rochester Electronics Manufactured Components

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All recreations are done with the approval of the OCM.

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceed the OCM data sheet.

Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-35835
 - Class Q Military
 - Class V Space Level
- Qualified Suppliers List of Distributors (QSLD)
- Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OEM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.





FQP8N60C/FQPF8N60C

600V N-Channel MOSFET

General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction, electronic lamp ballasts based on half bridge topology.

Features

- 7.5A, 600V, $R_{DS(on)}$ = 1.2 Ω @V_{GS} = 10 V Low gate charge (typical 28 nC)
- Low Crss (typical 12 pF)
- Fast switching
- · 100% avalanche tested
- · Improved dv/dt capability



Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		FQP8N60C	FQPF8N60C	Units
V_{DSS}	Drain-Source Voltage		600		V
I _D	Drain Current - Continuous (T _C = 25°C)		7.5	7.5 *	Α
	- Continuous (T _C = 100°C)		4.6	4.6 *	Α
I_{DM}	Drain Current - Pulsed	(Note 1)	30	30 *	Α
V _{GSS}	Gate-Source Voltage		± 30		V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	2	30	mJ
I _{AR}	Avalanche Current	(Note 1)	7	.5	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	14.7		mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4	.5	V/ns
P_{D}	Power Dissipation (T _C = 25°C)		147	48	W
	- Derate above 25°C		1.18	0.38	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150		°C
T _L	Maximum lead temperature for soldering pur 1/8" from case for 5 seconds	poses,	3	00	°C

^{*} Drain current limited by maximum junction temperature.

Thermal Characteristics

Symbol	Parameter	FQP8N60C	FQPF8N60C	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.85	2.6	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink Typ.	0.5		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	62.5	°C/W

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	600			V
ΔBV _{DSS} / ΔΤ _J	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		0.7		V/°C
I _{DSS}		V _{DS} = 600 V, V _{GS} = 0 V			1	μΑ
	Zero Gate Voltage Drain Current	V _{DS} = 480 V, T _C = 125°C			10	μA
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V			-100	nA
On Cha	racteristics					
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 μA	2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 3.75 A		1.0	1.2	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 3.75 A (Note 4)		8.7		S
C _{iss}	Input Capacitance Output Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz		965 105	1255 135	pF pF
C _{rss}	Reverse Transfer Capacitance			12	16	pF
Switchi	ing Characteristics					
t _{d(on)}	Turn-On Delay Time	V _{DD} = 300 V, I _D = 7.5A,		16.5	45	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$		60.5	130	ns
t _{d(off)}	Turn-Off Delay Time			81	170	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		64.5	140	ns
Qg	Total Gate Charge	V _{DS} = 480 V, I _D = 7.5A,		28	36	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V		4.5		nC
Q _{gd}	Gate-Drain Charge	(Note 4, 5)		12		nC
Drain-S	Source Diode Characteristics a	nd Maximum Ratings				
I _S	Maximum Continuous Drain-Source Did			7.5	Α	
I _{SM}	Maximum Pulsed Drain-Source Diode F	Forward Current		-	30	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 7.5 A			1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 7.5 A,		365		ns
Q _{rr}	Reverse Recovery Charge	$dI_F / dt = 100 A/\mu s$ (Note 4)		3.4		μС

- Notes:
 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 7.3mH, I_{AS} = 7.5 A, V_{DD} = 50V, R_G = 25 Ω, Starting T_J = 25°C 3. I_{SD} ≤ 7.5A, di/dt ≤ 200A/μs, V_{DD} ≤ BV_{DSS}, Starting T_J = 25°C 4. Pulse Test : Pulse width ≤ 300μs, Duty cycle ≤ 2% 5. Essentially independent of operating temperature

Typical Characteristics

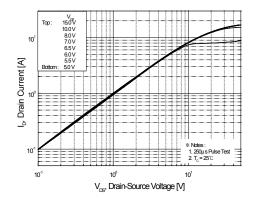


Figure 1. On-Region Characteristics

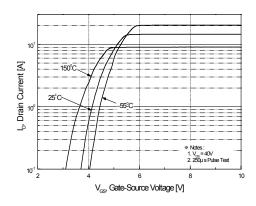


Figure 2. Transfer Characteristics

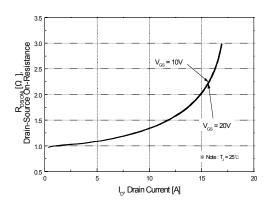


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

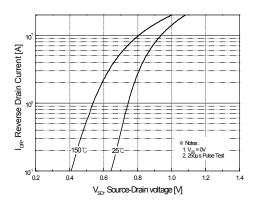


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

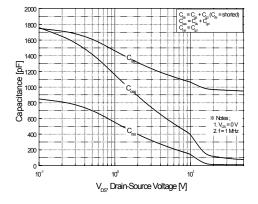


Figure 5. Capacitance Characteristics

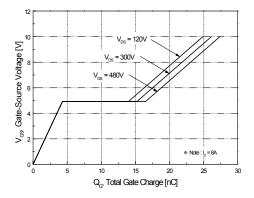


Figure 6. Gate Charge Characteristics

©2004 Fairchild Semiconductor Corporation Rev. B, March 2004

Typical Characteristics (Continued)

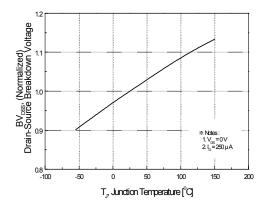


Figure 7. Breakdown Voltage Variation vs Temperature

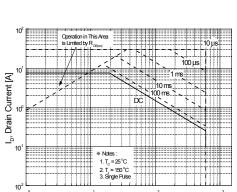


Figure 9-1. Maximum Safe Operating Area for FQP8N60C

 $V_{_{\!DS}}$, Drain-Source Voltage [V]

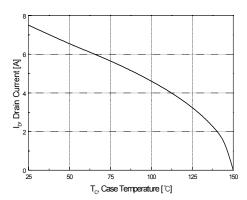


Figure 10. Maximum Drain Current vs Case Temperature

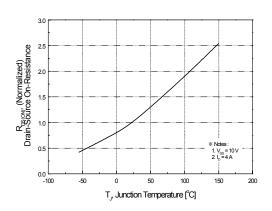


Figure 8. On-Resistance Variation vs Temperature

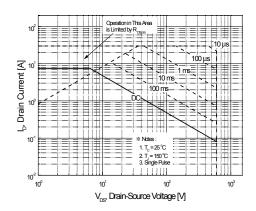


Figure 9-2. Maximum Safe Operating Area for FQPF8N60C

Rev. B, March 2004

Typical Characteristics (Continued)

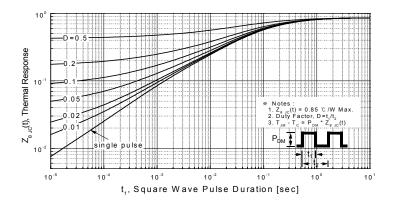


Figure 11-1. Transient Thermal Response Curve for FQP8N60C

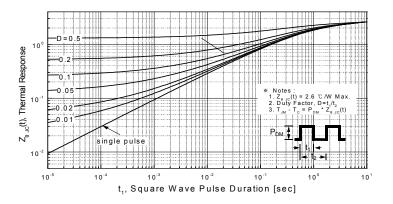
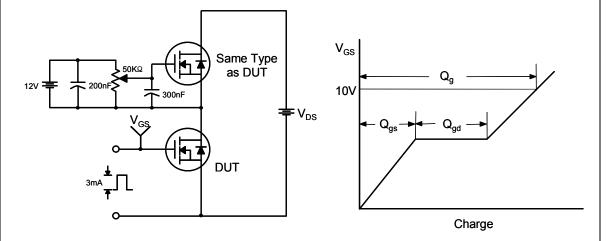


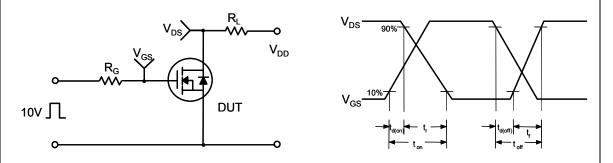
Figure 11-2. Transient Thermal Response Curve for FQPF8N60C

92004 Fairchild Semiconductor Corporation Rev. B, March 2004

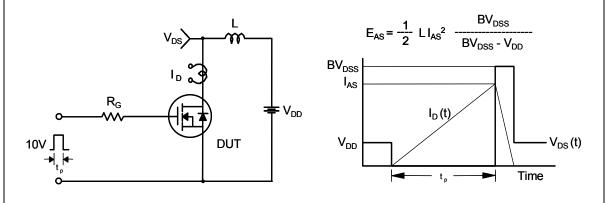
Gate Charge Test Circuit & Waveform



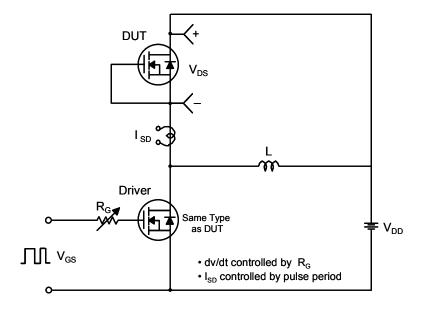
Resistive Switching Test Circuit & Waveforms

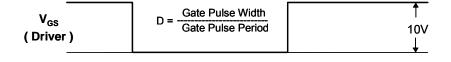


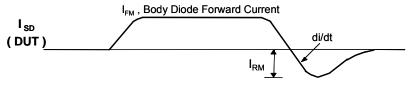
Unclamped Inductive Switching Test Circuit & Waveforms



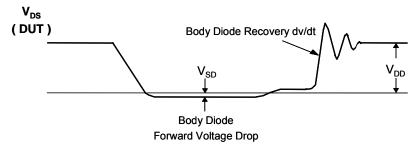
Peak Diode Recovery dv/dt Test Circuit & Waveforms

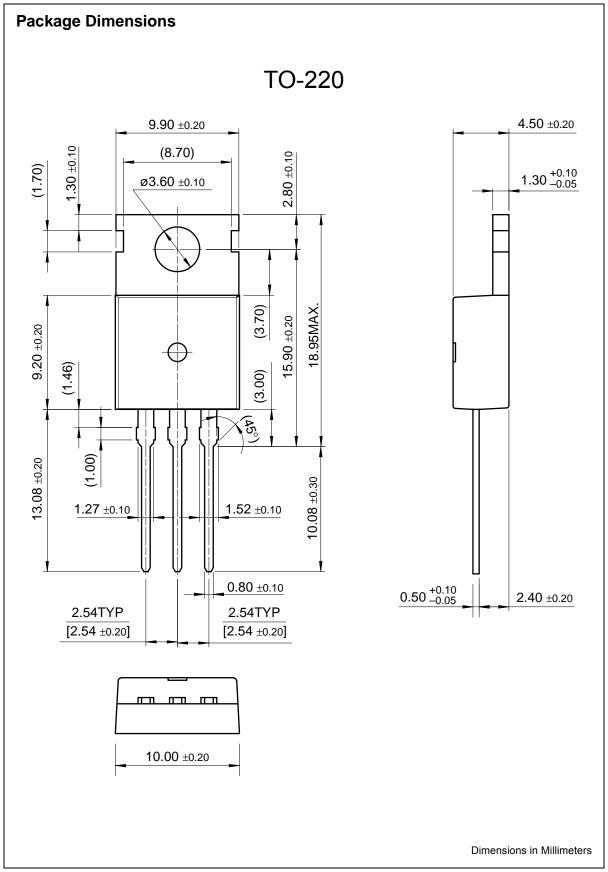


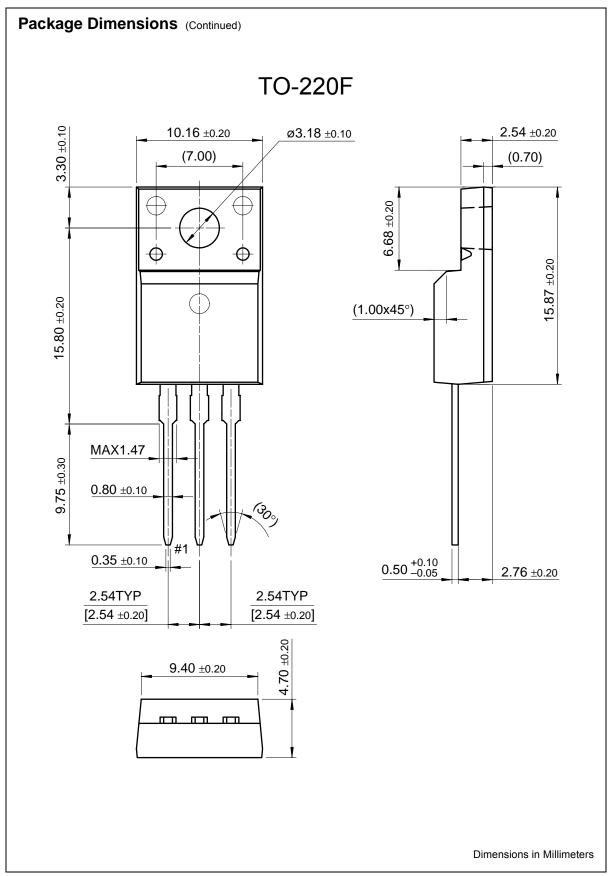




Body Diode Reverse Current







TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACEx™	FACT Quiet series™	ISOPLANAR™	POP™	Stealth™
ActiveArray™	FAST [®]	LittleFET™	Power247™	SuperFET™
Bottomless™	FASTr™	MICROCOUPLER™	PowerSaver™	SuperSOT™-3
CoolFET™	FPS™	MicroFET™	PowerTrench [®]	SuperSOT™-6
$CROSSVOLT^{\text{IM}}$	FRFET™	MicroPak™	QFET™	SuperSOT™-8
DOME™	GlobalOptoisolator™	MICROWIRE™	QS™	SyncFET™
EcoSPARK™	GTO™	MSX™	QT Optoelectronics™	TinyLogic [®]
E ² CMOS™	HiSeC™	MSXPro™	Quiet Series™	TINYOPTO™
EnSigna™	I ² C™	OCX™	RapidConfigure™	TruTranslation™
FACT™	ImpliedDisconnect™	OCXPro™	RapidConnect™	UHC™
Across the board.	Around the world.™	OPTOLOGIC [®]	SILENT SWITCHER®	UltraFET [®]
The Power Franci	hise [®]	OPTOPLANAR™	SMART START™	VCX™
Programmable Ad	ctive Droop™	PACMAN™	SPM™	

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

- 1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.
- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.

©2004 Fairchild Semiconductor Corporation Rev. 19

Search:

Go

DATASHEETS, SAMPLES, BUY TECHNICAL INFORMATION APPLICATIONS DESIGN CENTER SUPPORT COMPANY INVESTORS MY F.

Application notes

Qualification Support

Home >> Find products >>

FQPF8N60C

600V N-Channel Advance Q-FET C-Series

Contents

- General description
- Features
- Product status/pricing/packaging
- Order Samples

General description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction, electronic lamp ballasts based on half bridge topology.

BUY

Datasheet Download this datasheet



e-mail this datasheet



This page Print version

Related Links

Request samples

How to order products

Product Change Notices (PCNs)

Support

Sales support

Quality and reliability

Design center

back to top

Features

- 7.5A, 600V, R_{DS(on)} = 1.2 @V_{GS} = 10 V
- Low gate charge (typical 28 nC)
- Low Crss (typical 12 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability

back to top

Product status/pricing/packaging

BUY

Product	Product status	Pb-free Status	Pricing*	Package type	Leads	Packing method	Package Marking Convention**
							Line 1: \$Y (Fairchild logo)

FQPF8N60C	Full Production	Full Production	\$1.12	<u>TO-220F</u>	3	DAII	& Z (Asm. Plant Code) & 4 (4-Digit Date Code) <u>Line 2:</u> FQPF <u>Line 3:</u> 8N60C
FQPF8N60CT	Full Production	Full Production	\$1.14	TO-220F	3	RAIL	Line 1: \$Y (Fairchild logo) & Z (Asm. Plant Code) &E& 3 (3-Digit Date Code) Line 2: FQPF Line 3: 8N60CT
FQPF8N60CYDTU	Full Production	Full Production	\$1.26	TO-220F	3	RAIL	Line 1: \$Y (Fairchild logo) & Z (Asm. Plant Code) & 4 (4-Digit Date Code)

^{*} Fairchild 1,000 piece Budgetary Pricing

** A sample button will appear if the part is available through Fairchild's on-line samples program. If there is no sample button, please contact a Fairchild distributor to obtain samples



Indicates product with Pb-free second-level interconnect. For more information click here.

Package marking information for product FQPF8N60C is available. Click here for more information.

back to top

Application notes

AN-6014: AN-6014 Green Current Mode PWM Controller FAN7602 (390 K) Jul 27, 2007

back to top

Qualification Support

Click on a product for detailed qualification data

Product
FQPF8N60C
FQPF8N60CT
FQPF8N60CYDTU

back to top



Products Design Center Support Company News Investors My Fairchild Contact Us Site Index Privacy Policy Site Terms & Condition	ons Standard Terms & Conditions